

Replaces DS5606-6

DIM200PHM33-F000

Half Bridge IGBT Module

DS5606-7 March 2021 (LN40740)

FEATURES

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Soft Punch Through Silicon
- Isolated AISiC Base with AIN Substrates
- Lead Free Construction

APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- Traction Auxiliaries

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM200PHM33-F000 is a half bridge 3300V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA). This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM200PHM33-F000

Note: When ordering, please use the complete part number

KEY PARAMETERS

VCES		3300V
V _{CE(sat)} * ((typ)	2.8V
	(max)	200A
I _{C(PK)}	(max)	400A

* Measured at the auxiliary terminals

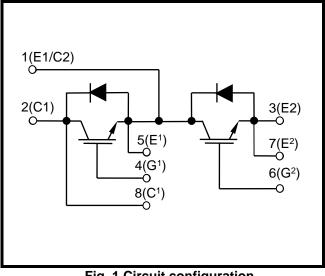
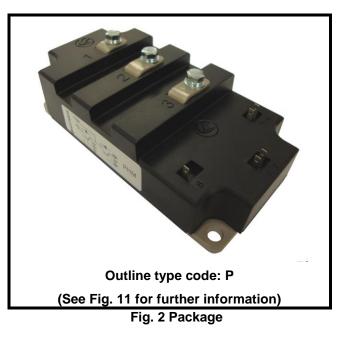


Fig. 1 Circuit configuration



Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures

ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Vces	Collector-emitter voltage	$V_{GE} = 0V$	3300	V
V _{GES}	Gate-emitter voltage		±20	V
lc	Continuous collector current	$T_{case} = 90^{\circ}C$	200	А
IC(PK)	Peak collector current	1ms, T _{case} = 115°C	400	А
P _{max}	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_j = 150^{\circ}C$	2.6	kW
l²t	Diode I ² t value	$V_R = 0, t_p = 10ms, T_j = 125^{\circ}C$	20	kA ² s
Visol	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	6000	V
Qpd	Partial discharge – per module	IEC1287, $V_1 = 3500V$, $V_2 = 2600V$, 50Hz RMS	10	рС

THERMAL AND MECHANICAL RATINGS

Internal insulation material:	AIN
Baseplate material:	AISiC
Creepage distance:	33mm
Clearance:	20mm
CTI (Comparative Tracking Index):	>600

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
R _{th(j-c)}	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	48	°C/kW
Rth(j-c)	Thermal resistance – Diode	Continuous dissipation - junction to case	-	-	96	°C/kW
Rth(c-h)	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	16	°C/kW
Tj	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T _{stg}	Storage temperature range -		-40	-	125	°C
	0	Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M5	-	-	4	Nm

ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}$			1	mA
I _{CES}		$V_{GE} = 0V$, $V_{CE} = V_{CES}$, $T_{case} = 125^{\circ}C$			15	mA
IGES	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$		400		nA
V _{GE(TH)}	Gate threshold voltage	Ic = 20mA, V _{GE} = V _{CE}	5.5	6.5	7.0	V
V +	Collector-emitter	V _{GE} = 15V, I _C = 200A		2.8		V
V _{CE(sat)} †	saturation voltage	$V_{GE} = 15V, I_C = 200A, T_j = 125^{\circ}C$		3.6		V
lF	Diode forward current	DC		200		А
Іғм	Diode maximum forward current tp = 1ms			400		А
		I _F = 200A		2.9		V
V _F †	Diode forward voltage	I _F = 200A, T _j = 125°C		3.0		V
Cies	Input capacitance	Input capacitance $V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		36		nF
Qg	Gate charge	±15V		5		μC
Cres	Reverse transfer capacitance	$V_{CE} = 25V$, $V_{GE} = 0V$, $f = 1MHz$		0.55		nF
L _M	Module inductance			40		nH
RINT	Internal transistor resistance			500		μΩ
SC _{Data}	Short circuit current, I _{SC}	$\begin{split} T_{j} &= 125^{\circ}C, \ V_{CC} = 2500V \\ t_{p} &\leq 10 \mu s, \ V_{GE} \leq 15V \\ V_{CE \ (max)} &= V_{CES} - L^{*} \ x \ dI/dt \\ IEC \ 60747-9 \end{split}$		930		A

Note:

 † Measured at the auxiliary terminals * L is the circuit inductance + L_{M}

ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Co	nditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time		$R_{G(ON)} = 16.5Ω$ $R_{G(OFF)} = 16.5Ω$		1.95		μs
t _f	Fall time	$I_{C} = 200A$ $V_{GE} = \pm 15V$ $V_{CE} = 1800V$ $C_{ge} = 56nF$ $L_{S} \sim 100nH$			170		ns
Eoff	Turn-off energy loss				220		mJ
t _{d(on)}	Turn-on delay time				1180		ns
tr	Rise time				225		ns
Eon	Turn-on energy loss		$R_{G(ON)} = 7.5\Omega,$ $R_{G(OFF)} = 16.5\Omega$		290		mJ
Q _{rr}	Diode reverse recovery charge	IF = 200A			80		μC
Irr	Diode reverse recovery current	V _{CE} =			144		А
Erec	Diode reverse recovery energy	dl _F /dt = 1600A/µs			75		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Co	nditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time		$R_{G(ON)} = 16.5\Omega$ $R_{G(OFF)} = 16.5\Omega$		2.2		μs
t _f	Fall time	I _C = 200A V _{GE} = ±15V			190		ns
E _{OFF}	Turn-off energy loss				265		mJ
t _{d(on)}	Turn-on delay time	V _{CE} = 1800V C _{ge} = 56nF			1150		ns
tr	Rise time	Ls ~ 100nH			280		ns
Eon	Turn-on energy loss		$\begin{aligned} R_{G(ON)} &= 7.5\Omega, \\ R_{G(OFF)} &= 16.5\Omega \end{aligned}$		390		mJ
Qrr	Diode reverse recovery charge	IF = 200A			125		μC
Irr	Diode reverse recovery current		1800V		155		А
Erec	Diode reverse recovery energy	dl⊧/dt = 1600A/µs			130		mJ

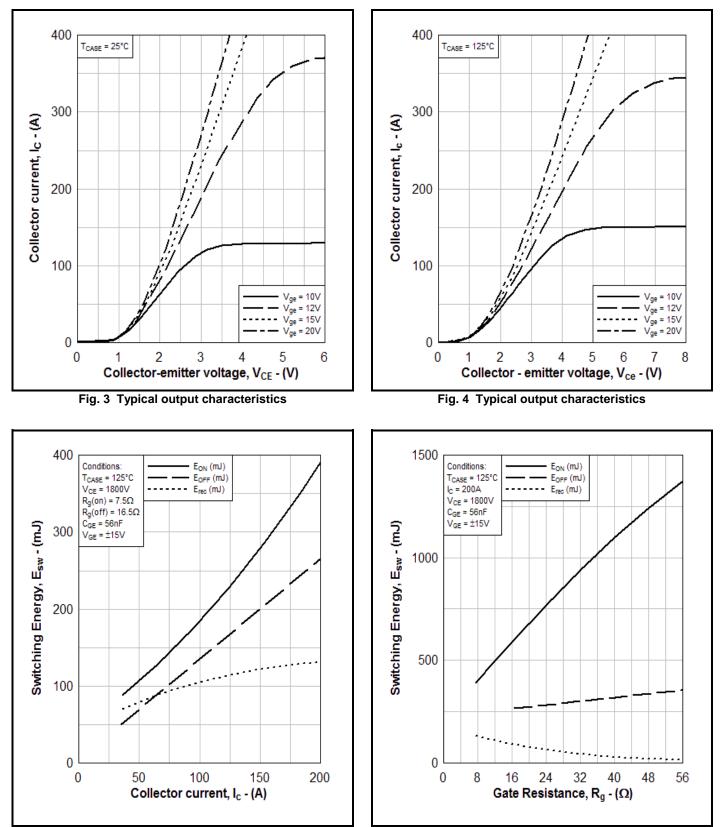


Fig. 5 Typical switching energy vs collector current Fig. 6 Typical switching energy vs gate resistance

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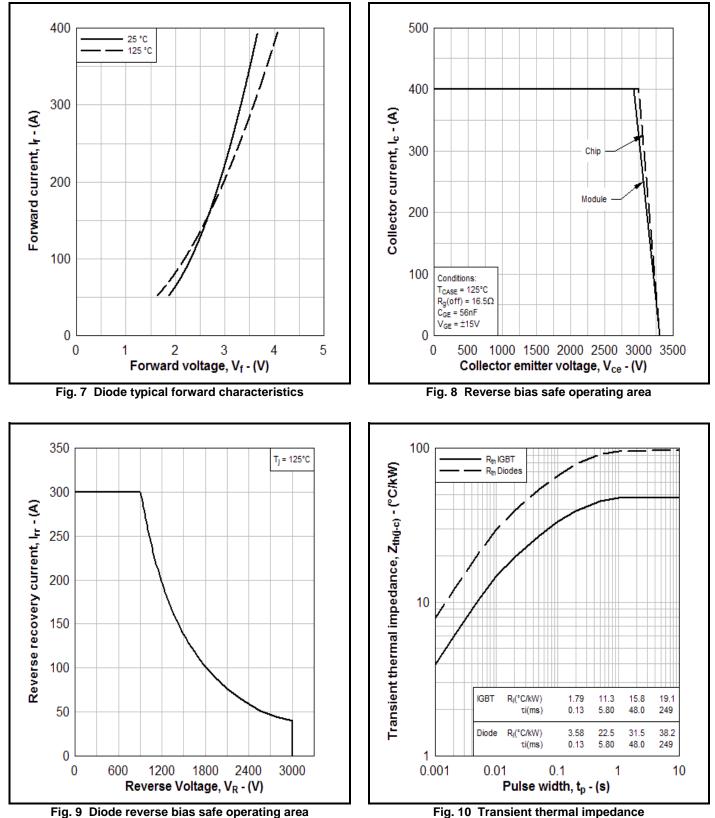
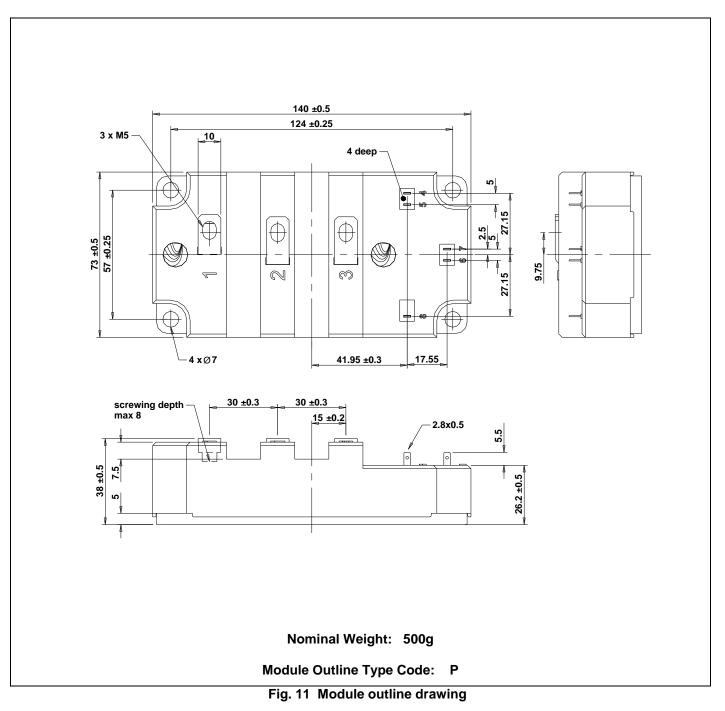


Fig. 10 Transient thermal impedance

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. **DO NOT SCALE.**



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Extended exposure to conditions outside the product ratings may affect reliability leading to premature product failure. Use outside the product ratings is likely to cause permanent damage to the product. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture, a large current to flow or high voltage arcing, resulting in fire or explosion. Appropriate application design and safety precautions should always be followed to protect persons and property.

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DYNEX SEMICONDUCTOR LTD

Doddington Road, Lincoln, Lincolnshire, LN6 3LF, United Kingdom Fax: +44(0)1522 500550 Tel: +44(0)1522 500500 Web: <u>http://www.dynexsemi.com</u>

CUSTOMER SERVICE

DYNEX SEMICONDUCTOR LTD

Doddington Road, Lincoln, Lincolnshire, LN6 3LF, United Kingdom

Tel: +44(0)1522 502753 / 502901 Email: <u>powersolutions@dynexsemi.com</u>

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